

Complete if Known Substitute for form 1449/PTO 10/614,342 Application Number July 8, 2003 INFORMATION DISCLOSURE Filing Date First Named Inventor Shinichi NAGAHAMA STATEMENT BY APPLICANT 2815 Art Unit (Use as many sheets as necessary) Examiner Name A. R. Wilson 204552029200 1 Attorney Docket Number

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Examiner	Cite	Document Number	Publication Date	Name of Patentee or	Pages, Columns, Lines, Where Relevant Passages or Relevant		
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Examiner Initials	Cite No.1	include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T²					
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	TATEMENT			First Named Inventor	Shinichi NAGAHAMA	
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